



SANYO Semiconductors

# DATA SHEET

## MCH3222 — NPN Epitaxial Planar Silicon Transistor

### DC / DC Converter Applications

#### Applications

- Relay drivers, lamp drivers, motor drivers, flash.

#### Features

- Adoption of FBET, MBIT processes.
- Large current capacitance.
- Low collector-to-emitter saturation voltage.
- High-speed switching.
- Narrow  $h_{FE}$  range.
- Ultrasmall package facilitates miniaturization in end products (mounting height : 0.85mm).
- High allowable power dissipation.

#### Specifications

##### Absolute Maximum Ratings at $T_a=25^\circ\text{C}$

Parameter	Symbol	Conditions	Ratings	Unit
Collector-to-Base Voltage	$V_{CB0}$		100	V
Collector-to-Emitter Voltage	$V_{CES}$		100	V
	$V_{CEO}$		50	V
Emitter-to-Base Voltage	$V_{EBO}$		6	V
Collector Current	$I_C$		3	A
Collector Current (Pulse)	$I_{CP}$	$PW \leq 1\text{ms}$	6	A
Base Current	$I_B$		600	mA
Collector Dissipation	$P_C$	Mounted on a ceramic board (600mm <sup>2</sup> X0.8mm)	0.8	W
Junction Temperature	$T_J$		150	$^\circ\text{C}$
Storage Temperature	$T_{stg}$		-55 to +150	$^\circ\text{C}$

##### Electrical Characteristics at $T_a=25^\circ\text{C}$

Parameter	Symbol	Conditions	Ratings			Unit
			min	typ	max	
Collector Cutoff Current	$I_{CBO}$	$V_{CB}=40\text{V}, I_E=0\text{A}$			0.1	$\mu\text{A}$
Emitter Cutoff Current	$I_{EBO}$	$V_{EB}=4\text{V}, I_C=0\text{A}$			0.1	$\mu\text{A}$
DC Current Gain	$h_{FE}$	$V_{CE}=2\text{V}, I_C=100\text{mA}$	250		400	
Gain-Bandwidth Product	$f_T$	$V_{CE}=10\text{V}, I_C=500\text{mA}$		380		MHz

Marking : CV

Continued on next page.

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**SANYO Semiconductor Co., Ltd.**

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# MCH3222

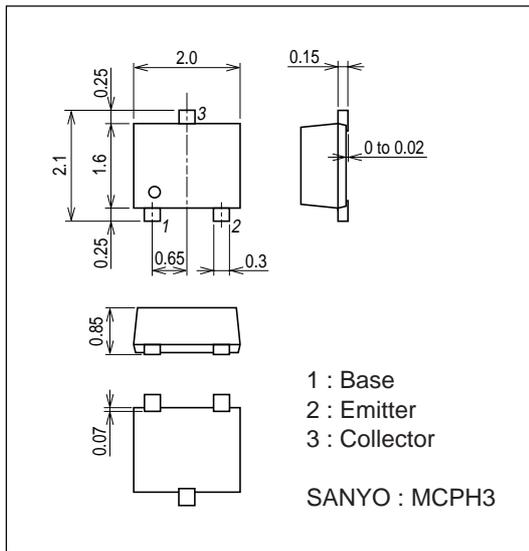
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Parameter	Symbol	Conditions	Ratings			Unit
			min	typ	max	
Output Capacitance	Cob	V <sub>CB</sub> =10V, f=1MHz		13		pF
Collector-to-Emitter Saturation Voltage	V <sub>CE(sat)1</sub>	I <sub>C</sub> =1A, I <sub>B</sub> =50mA		60	90	mV
	V <sub>CE(sat)2</sub>	I <sub>C</sub> =2A, I <sub>B</sub> =100mA		100	150	mV
Base-to-Emitter Saturation Voltage	V <sub>BE(sat)</sub>	I <sub>C</sub> =2A, I <sub>B</sub> =100mA		0.88	1.2	V
Collector-to-Base Breakdown Voltage	V <sub>(BR)CBO</sub>	I <sub>C</sub> =10μA, I <sub>E</sub> =0A	100			V
Collector-to-Emitter Breakdown Voltage	V <sub>(BR)CES</sub>	I <sub>C</sub> =100μA, R <sub>BE</sub> =0Ω	100			V
	V <sub>(BR)CEO</sub>	I <sub>C</sub> =1mA, R <sub>BE</sub> =∞	50			V
Emitter-to-Base Breakdown Voltage	V <sub>(BR)EBO</sub>	I <sub>E</sub> =10μA, I <sub>C</sub> =0A	6			V
Turn-ON Time	t <sub>on</sub>	See specified Test Circuit.		35		ns
Storage Time	t <sub>stg</sub>	See specified Test Circuit.		300		ns
Fall Time	t <sub>f</sub>	See specified Test Circuit.		22		ns

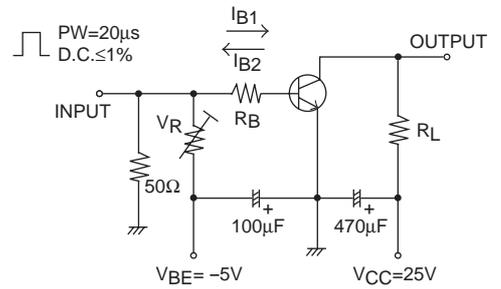
## Package Dimensions

unit : mm

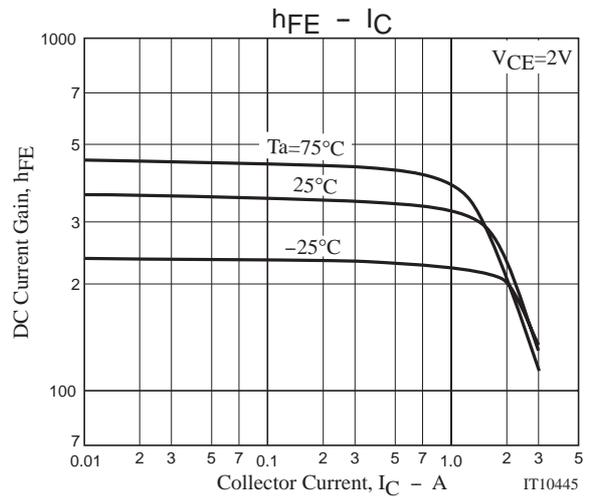
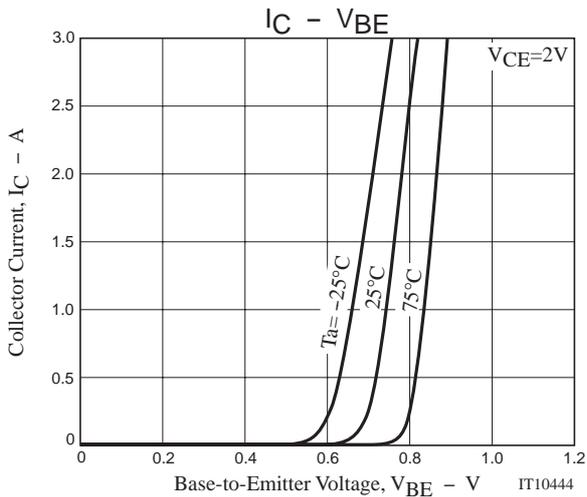
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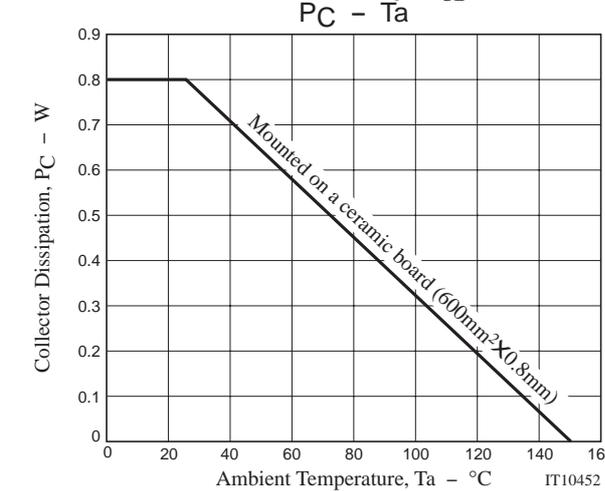
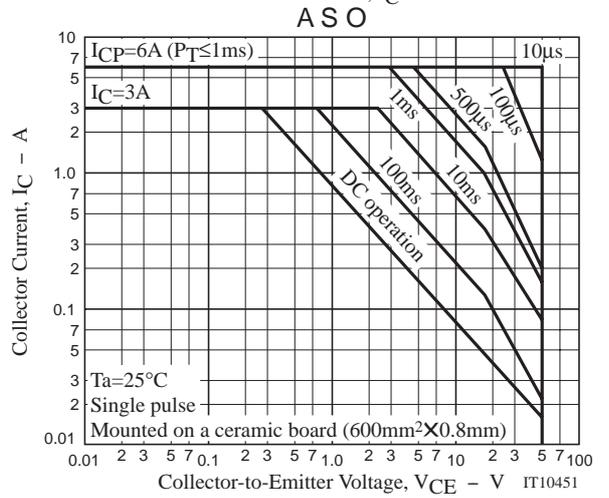
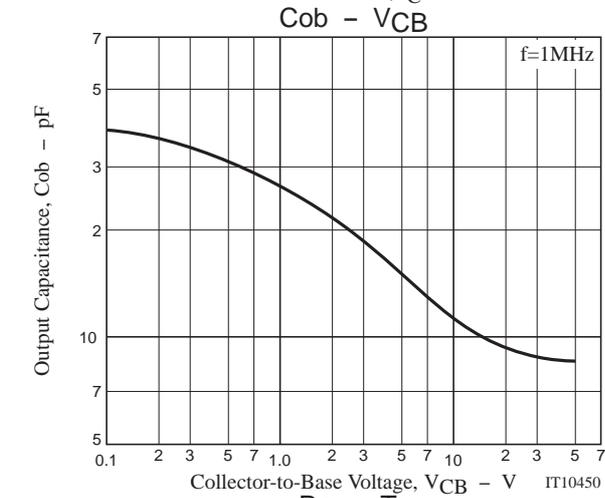
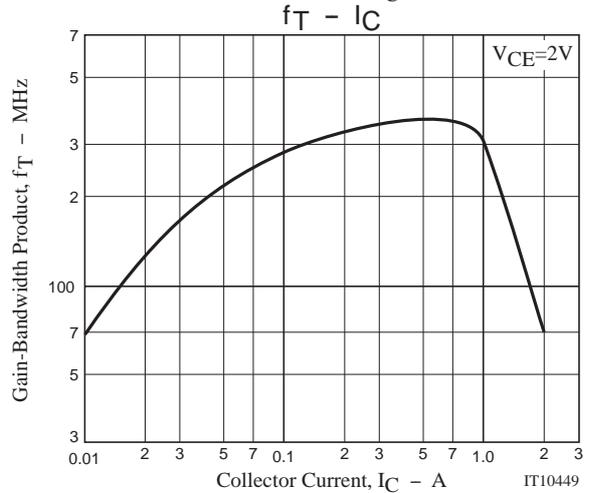
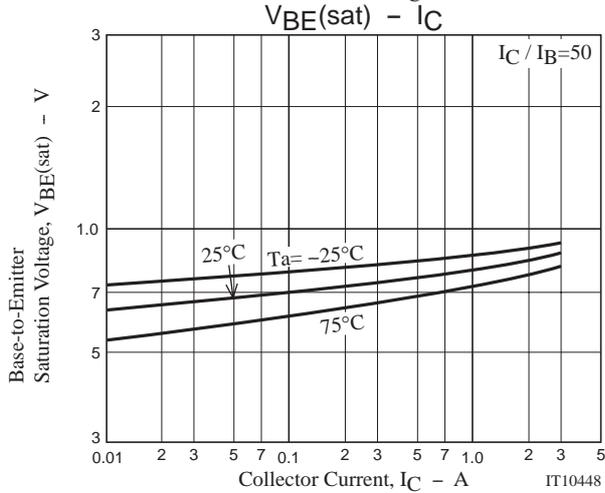
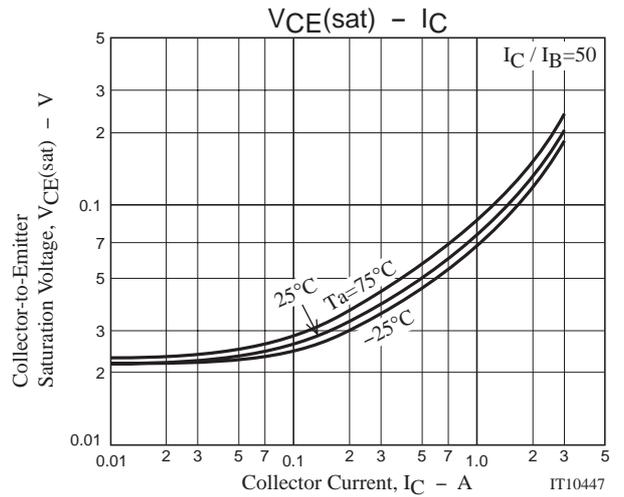
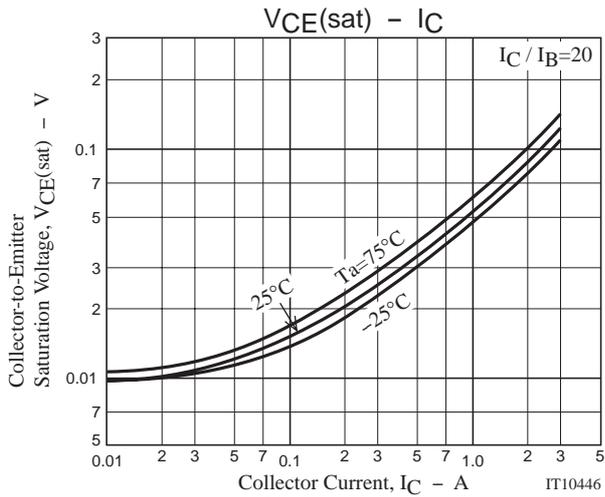
## Switching Time Test Circuit



$$I_C = 10I_{B1} = -10I_{B2} = 1A$$



# MCH3222



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